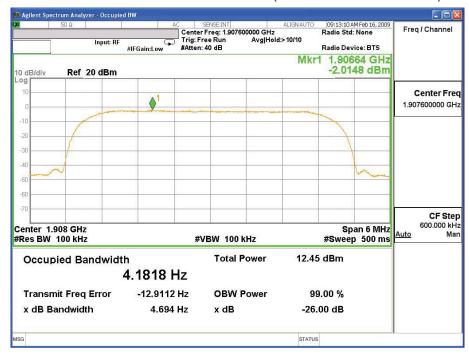


Product	HSUPA PCI Express mini card module		
Test Mode	Occupied Bandwidth		
Date of Test	2009/02/18	Test Site	CTR
Test Condition	WCDMA BAND II		

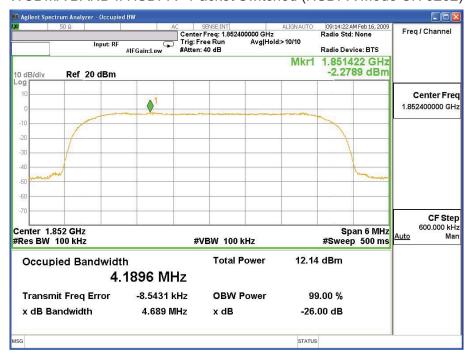
WCDMA BAND II - Packet Switched (WCDMA Mode CH 9538)



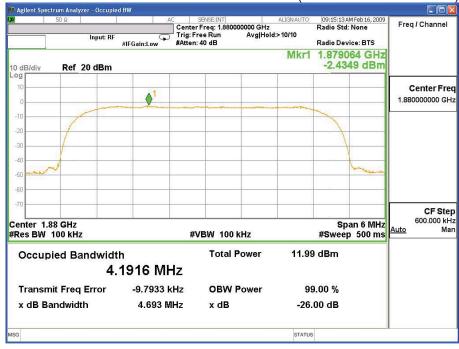


Product	HSUPA PCI Express mini card module		
Test Mode	Occupied Bandwidth		
Date of Test	2009/02/18	Test Site	CTR
Test Condition	WCDMA BAND II HSDPA		

WCDMA BAND II HSDPA - Packet Switched (HSDPA Mode CH 9262)



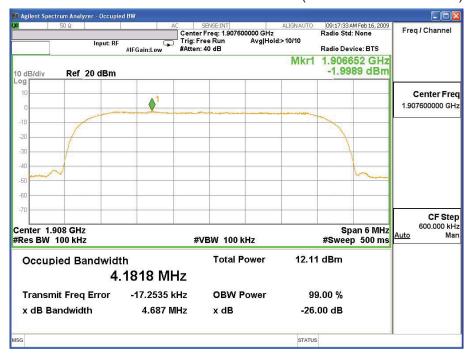
WCDMA BAND II HSDPA - Packet Switched (HSDPA Mode CH 9400)





Product	HSUPA PCI Express mini card module		
Test Mode	Occupied Bandwidth		
Date of Test	2009/02/18	Test Site	CTR
Test Condition	WCDMA BAND II HSDPA		

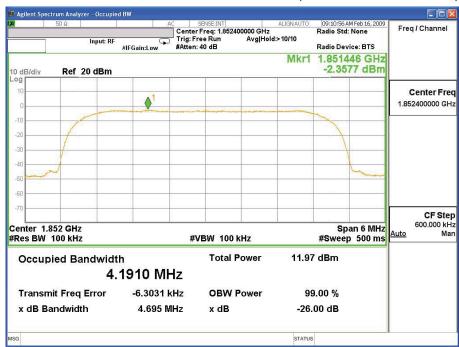
WCDMA BAND II HSDPA - Packet Switched (HSDPA Mode CH 9538)



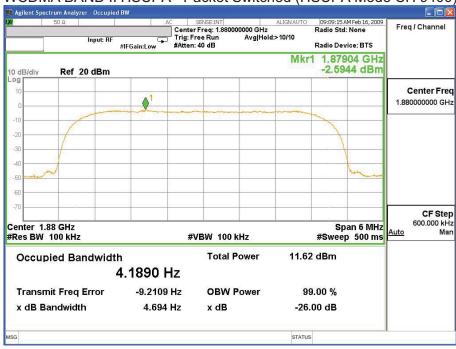


Product	HSUPA PCI Express mini card module		
Test Mode	Occupied Bandwidth		
Date of Test	2009/02/18 Test Site CTR		
Test Condition	WCDMA BAND II HSUPA		

WCDMA BAND II HSUPA - Packet Switched (HSUPA Mode CH 9262)



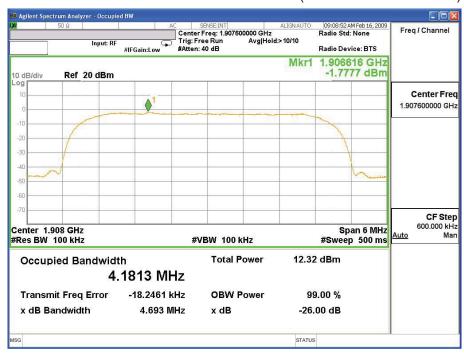
WCDMA BAND II HSUPA - Packet Switched (HSUPA Mode CH 9400)





Product	HSUPA PCI Express mini card module		
Test Mode	Occupied Bandwidth		
Date of Test	2009/02/18	Test Site	CTR
Test Condition	WCDMA BAND II HSUPA		

WCDMA BAND II HSUPA - Packet Switched (HSUPA Mode CH 9538)





4. Spurious Emission At Antenna Terminals (+/-1MHz)

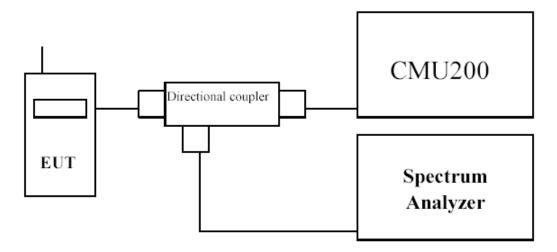
4.1. Test Equipment

The following test equipments are used during the spurious emission test

Equipment	Manufacturer	Model No./Serial No.	Last Cal.
Spectrum Analyzer	Advantest	R3182 / 100803470	May, 2008
Universal Radio Communication Tester	R&S	CMU200 / 104846	Apr., 2008
Directional coupler	Agilent	87300C / MY44300353	Aug., 2008
Directional coupler	Agilent	778D-012/ 50550	Aug., 2008

Note: All equipments upon which need to be calibrated are with calibration period of 1 year.

4.2. Setup





4.3. Limits

Cellular Band Transmitter limits for narrowband spurious emission

Lower Block Edge Test Frequencies	Upper Block Edge Test Frequencies
Block A	Block B
Channel : 128	Channel : 251
Frequency : 824.2 MHz	Frequency : 848.8 MHz

PCS Band Transmitter limits for narrowband spurious emission

Lower Block Edge Test Channels/Frequencies	Upper Block Edge Test Channels/Frequencies
Block A	Block C
Channel : 512	Channel : 810
Frequency : 1850.2 MHz	Frequency : 1909.8 MHz

4.4. Test Procedure

In accordance with Part 22.917 and 24.238, at least 1% of the emission bandwidth was used for the resolution and video bandwidths up to 1MHz away from the Block Edge. At greater than 1MHz, the resolution and video bandwidth were increased to 1MHz.

The reference power and path losses of all channels used for testing in each frequency block were measured.

4.5. Test Specification

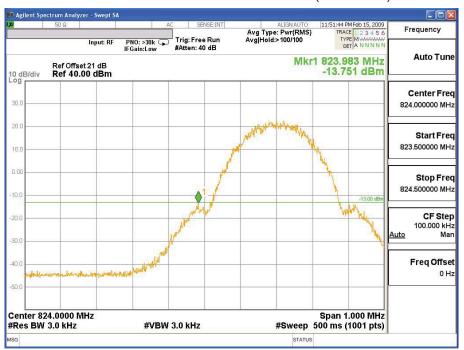
According to Part 2.1049, 22.917,24.238.



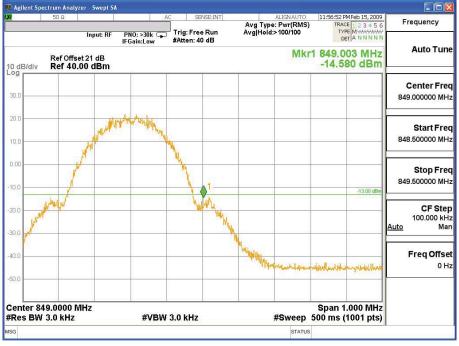
4.6. Test Result of Spurious Emission At Antenna Terminals (+/-1MHz)

Product	HSUPA PCI Express mini card module		
Test Mode	Spurious Emission At Antenna Terminals (+/-1MHz)		
Date of Test	2009/02/18 Test Site CTR		
Test Condition	Block Edge Test (GSM 850 GPRS)		

GSM 850 GPRS Lower Channel 128 (824.2MHz)



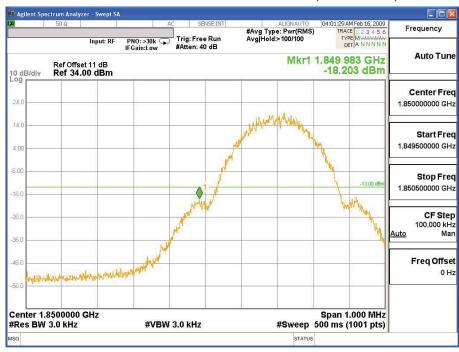




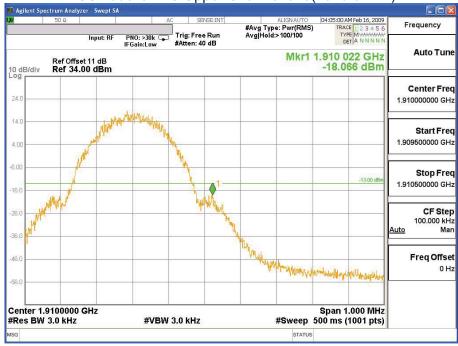


Product	HSUPA PCI Express mini card module		
Test Mode	Spurious Emission At Antenna Terminals (+/-1MHz)		
Date of Test	2009/02/18 Test Site CTR		
Test Condition	Block Edge Test (PCS 1900 GPRS)		

PCS 1900 GPRS Lower Channel 512 (1850.2MHz)



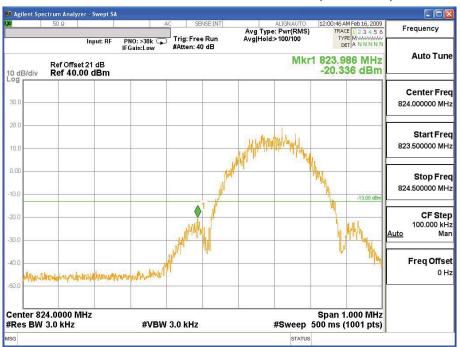




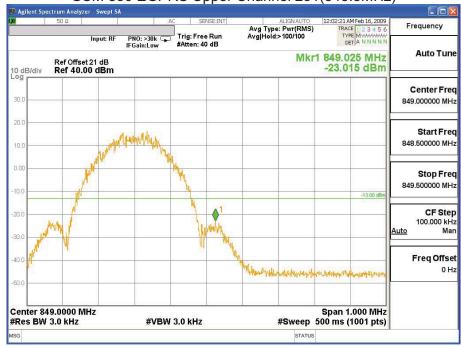


Product	HSUPA PCI Express mini card module		
Test Mode	Spurious Emission At Antenna Terminals (+/-1MHz)		
Date of Test	2009/02/18	Test Site	CTR
Test Condition	Block Edge Test (GSM 850 EGPRS)		

GSM 850 EGPRS Lower Channel 128 (824.2MHz)



GSM 850 EGPRS Upper Channel 251(848.8MHz)



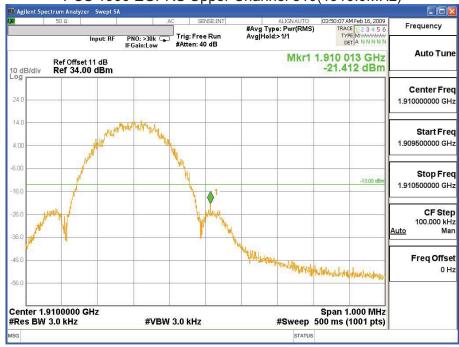


Product	HSUPA PCI Express mini card module		
Test Mode	Spurious Emission At Antenna Terminals (+/-1MHz)		
Date of Test	2009/02/18 Test Site CTR		
Test Condition	Block Edge Test (PCS 1900 EGPRS)		

PCS 1900 EGPRS Lower Channel 512 (1850.2MHz)



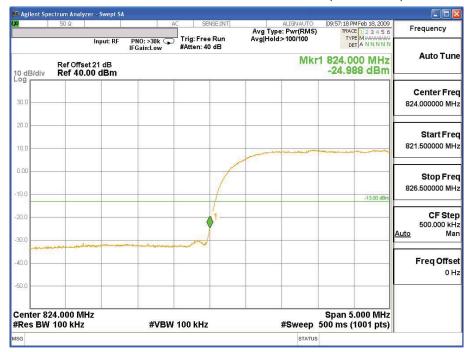




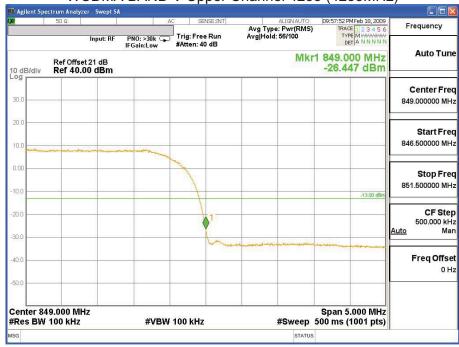


Product	HSUPA PCI Express mini card module		
Test Mode	Spurious Emission At Antenna Terminals (+/-1MHz)		
Date of Test	2009/02/18	Test Site	CTR
Test Condition	Block Edge Test (WCDMA BAND V)		

WCDMA BAND V Lower Channel 4132 (826.4MHz)



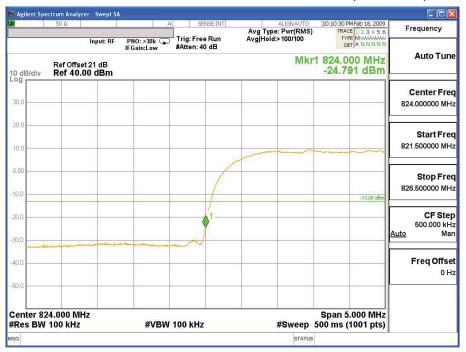




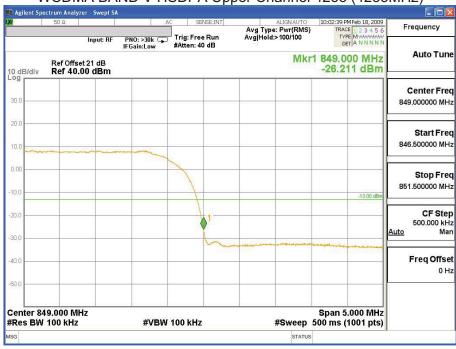


Product	HSUPA PCI Express mini card module		
Test Mode	Spurious Emission At Antenna Terminals (+/-1MHz)		
Date of Test	2009/02/18	Test Site	CTR
Test Condition	Block Edge Test (WCDMA BAND V HSDPA)		

WCDMA BAND V HSDPA Lower Channel 4132 (826.4MHz)



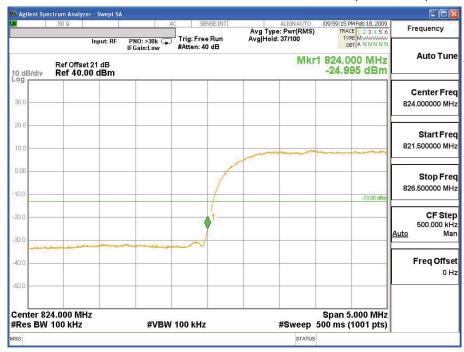
WCDMA BAND V HSDPA Upper Channel 4233 (4233MHz)



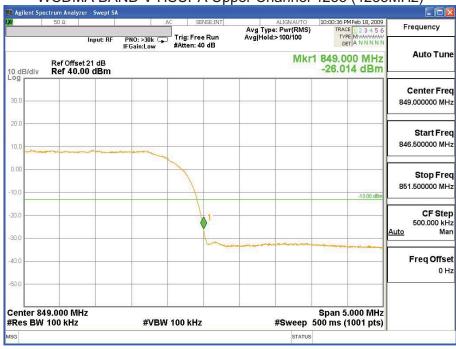


Product	HSUPA PCI Express mini card module		
Test Mode	Spurious Emission At Antenna Terminals (+/-1MHz)		
Date of Test	2009/02/18	Test Site	CTR
Test Condition	Block Edge Test (WCDMA BAND V HSUPA)		

WCDMA BAND V HSUPA Lower Channel 4132 (826.4MHz)



WCDMA BAND V HSUPA Upper Channel 4233 (4233MHz)



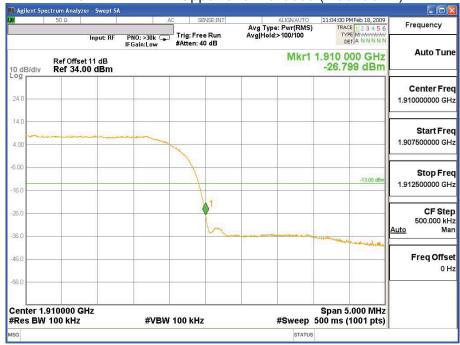


Product	HSUPA PCI Express mini card module		
Test Mode	Spurious Emission At Antenna Terminals (+/-1MHz)		
Date of Test	2009/02/18	Test Site	CTR
Test Condition	Block Edge Test (WCDMA BAND II)		

WCDMA BAND II Lower Channel 9262 (1.8524GHz)









Product	HSUPA PCI Express mini card module		
Test Mode	Spurious Emission At Antenna Terminals (+/-1MHz)		
Date of Test	e of Test 2009/02/18 Test Site CTR		CTR
Test Condition	Block Edge Test (WCDMA BAND II HSDPA)		

WCDMA BAND II HSDPA Lower Channel 9262 (1.8524GHz)



WCDMA BAND II HSDPA Upper Channel 9538 (1.9076GHz)



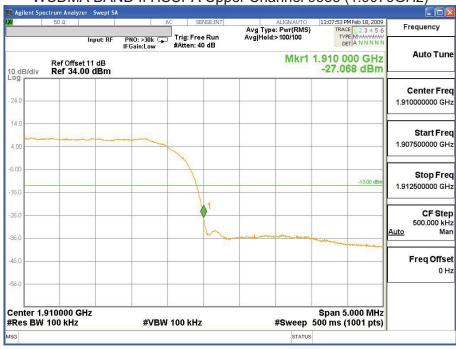


Product	HSUPA PCI Express mini card module		
Test Mode	Spurious Emission At Antenna Terminals (+/-1MHz)		
Date of Test	te of Test 2009/02/18 Test Site CTR		CTR
Test Condition	Block Edge Test (WCDMA BAND II HSUPA)		

WCDMA BAND II HSUPA Lower Channel 9262 (1.8524GHz)



WCDMA BAND II HSUPA Upper Channel 9538 (1.9076GHz)





5. **Spurious Emission**

5.1. **Test Equipment**

The following test equipments are used during the radiated emission test:

Equipment	Manufacturer	Model No./Serial No.	Last Cal.
Spectrum Analyzer	Agilent	N9020A/ MY48010570	Apr., 2008
Dual Directional couple	Agilent	778D-012/50550	Aug , 2008
Directional coupler	Agilent	87300C/ MY44300353	Aug ., 2008
Bilog Antenna	Schaffner Chase	CBL6112B/2921	Aug ., 2008
Broadband Horn Antenna	Schwarzbeck	BBHA9170/497	Sep ., 2008
Horn Antenna	Schwarzbeck	BBHA9120D/ 305	Sep ., 2008
Pre-Amplifier	QTK	N/A	N/A
Microwave Amplifier (0.5GHZ-26.5GHZ)	Agilent	83017A/ MY39500682	Aug ., 2008
Spectrum Analyzer (9K-40GHz)	R&S	FSP40/100339	Nov ., 2008
Universal Radio Communication Tester	R&S	CMU200 / 104846	Apr ., 2008

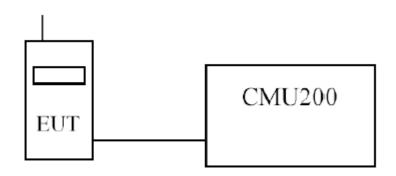
Note:

- All equipments that need to be calibrated are with calibration period of 1 year.
 Mark "X" test instruments are used to measure the final test results.

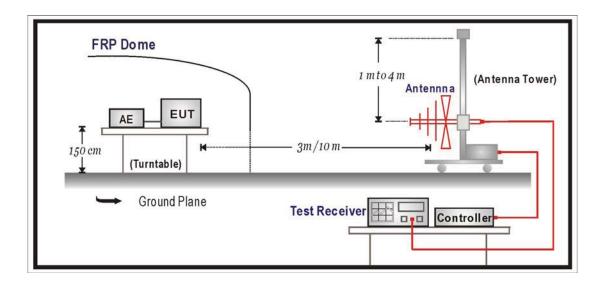


5.2. Test Setup

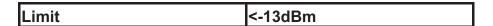
5.2.1 Spurious emissions at antenna terminals.



5.2.2 Field strength of spurious radiation.



5.3. Limits



43 + 10Log(P) down on the carrier where P is the power in Watts.